

## **SYSTEM AND METHOD FOR BROADBAND ANALYSIS OF TELEPHONE LOCAL LOOP**

### **Field of the Invention**

The present invention is related to communication systems and methods for analyzing same, and more particularly, this invention relates to  
5 qualifying and quantifying a telephone local loop for wideband services and recommending the best technology in wideband services for the local loop under test.

### **Background of the Invention**

10 Broadband services supplied to a customer over the copper local loop are becoming increasingly more popular with the rise of the Internet and other technologies requiring wideband local loop applications. It is well known that Digital Subscriber  
15 Line (DSL) technology improves the bandwidth of existing analog phone systems. Data throughput of up to 52 Mbits/sec can be provided over small distances, which increase as the data rate is lowered.

The customer local loop refers to the  
20 existing twisted-pair wire that extends between a local telephone company switching office and most homes and offices. As is well known, the bandwidth was typically limited to 3,000 Hz, because of the relegation of the local twisted-pair wire to the voice telephone system  
25 and its audio frequencies. In the past, most telephone switching equipment was designed to cut off signals

from about 4,000 Hz and filter noise off the voice line.

More phone companies are upgrading their switching equipment to obtain a greater bandwidth since the advent of the Internet. The different technologies  
5 of DSL, also referred to as xDSL, range in speed from 16K bits/sec to 52 Mbits/sec, and can be either symmetrical, where traffic flows at the same speed in both directions or asymmetrical, where the downstream capacity is higher than the upstream capacity.

10 Asymmetrical DSL services can typically be used by Internet users at home, for example, allowing a user to download more graphic files and upload only commands.

As the data rate increases, the carrying distance for xDSL service decreases. Also, xDSL  
15 connections are point-to-point and are always connected with no dial up, and no switching. There is always a direct connection into a carrier's frame relay, ATM (Asynchronous Transfer Mode), or an Internet-connect system.

20 The different types of xDSL service include High-bit-rate Digital Subscriber Line (HDSL), which provides T1 data rates of 1.544 Mbits/sec over about 12,000 feet of line length. Two lines are used and voice services are not operable. It is usually  
25 provided for feeder lines, interexchange connections, Internet servers, and private data networks.

Symmetrical Digital Subscriber Line (SDSL) is a symmetrical, bidirectional DSL service using one twisted-pair wire and operates above the voice  
30 frequency. This allows voice and data to be carried on the same wire.

Asymmetrical Digital Subscriber Line (ADSL) allows a much greater downstream data rate. It is operable best for Internet services and the rate  
35 varies, depending on the downstream rate and downstream

distance. For example, when using a downstream rate of 1.544 Mbits/sec, the downstream maximum line distance is about 18,000 feet. If the downstream rate is increased to 8.448 Mbits/sec, the downstream maximum  
5 line distance is only about 9,000 feet.

Very high-bit-rate Digital Subscriber Line (VDSL) is a very high asymmetrical data rate. It allows an upstream rate of about 12.96 Mbits/sec with a maximum line distance of about 4,500 feet, and an  
10 upstream rate of about 51.84 Mbits/sec, with an upstream maximum line distance of about 1,000 feet.

Rate-Adaptive Digital Subscriber Line (RADSL) is similar to ADSL, but includes a rate-adapted feature to adjust transmission speed to match the quality of  
15 the line and length of the line. It is possible to use a line-pulling technique to establish a connection speed when the line is first established.

ISDN DSL (IDSL) operates at about 128 Kbps, which is less than most other DSL technologies. It is  
20 a dedicated service as compared to standard ISDN services. IDSL is data-only and lacks any analog voice line.

Although xDSL technologies are becoming increasingly important, there is still an inability to  
25 adequately prequalify the local copper loops accurately. This has been a significant obstacle for the Local Exchange Carriers (LECS). Prequalification has now become critical because the different xDSL technology services is dependent on the design and  
30 quality of the outside plant (OSP) and the presence of load coils, which block DSL transmission. Prequalification also determines if the local loop is capable of supporting DSL transmission prior to any attempt to provide service. There will be significant  
35 cost savings for the LEC if the loop could be qualified

without having to dispatch technicians to either a central office (CO) or to the customer premises. As noted above, there are a number of DSL services and even more are projected by the industry. Thus, there  
5 is a strong need for an even more improved automated testing capability to handle the growing line volume of xDSL technologies. It is necessary, then, to predict a local loop's capability to support xDSL services across an entire range of frequencies over which this  
10 technology can operate.

There are some systems for estimating the ability of a subscriber loop to support broadband services, such as disclosed in U.S. Patent No. 6,091,713 to Lechleter et al. Also, there are various  
15 Wideband Test Packs (WTP) and Remote Test Units (RTU), such as manufactured by Harris Corporation of Melbourne, Florida, that are used for diagnosing service-affecting problems for all xDSL and ISDN services. These units can act as an intelligent test  
20 head, as known to those skilled in the art. Greater efficiency in testing, qualifying, and quantifying the local loop is desired, however.

#### Summary of the Invention

25 It is therefore an object of the present invention to provide an improved method and system of analyzing a telephone local loop for broadband services.

In accordance with the present invention, the  
30 method and system analyzes a telephone local loop by first determining the physical loop faults within the local loop. The local loop is qualified for a particular Digital Subscriber Line (DSL) technology. The local loop is then quantified by calculating the  
35 signal-to-noise ratio and calculating the data rates of

the local loop for a particular DSL technology. In one aspect of the present invention, the DSL technology comprises symmetric DSL technology, and in another aspect of the present invention, it comprises  
5 asymmetric DSL technology.

In yet another aspect of the present invention, the local loop is quantified by modeling the local loop, including the resistance, inductance, capacitance and conductance (RLCG) primary constants  
10 and the line parameters for various segments of the local loop. The line parameters can be modeled based on the frequency and RLCG primary constants.

Physical loop faults can be determined by obtaining plant data and test results from a test head  
15 within a communications network containing the local loop. The local loop can be qualified by testing for the presence or absence of load coils, impulse noise counts and ringer counts, and then comparing the counts with thresholds specified by given DSL technologies.

20 The local loop can be quantified by calculating downstream and upstream data rates based on the downstream and upstream transmit signal power spectral densities, insertion loss, and noise versus frequency measurements. The insertion loss of the local loop can  
25 be calculated with or without bridge tabs based on the cable type, wire gauge, loop length and its topology. The local loop can also be quantified by selecting a particular DSL technology from a configurable list of DSL technologies and analyzing each technology within  
30 the list until the local loop qualifies.

#### **Brief Description of the Drawings**

Other objects, features and advantages of the present invention will become apparent from the  
35 detailed description of the invention which follows,

when considered in light of the accompanying drawings in which:

FIG. 1 is a block diagram of a network element interconnection that uses a Remote Testing Unit and Wideband Test Pack for testing the local loop, in accordance with one aspect of the present invention.

FIG. 2 is a high level flow chart illustrating one basic method used in the present invention for analyzing the local loop for wideband services.

FIG. 3 is a more detailed flow chart of an example of the algorithm used for testing the local loop, in accordance with the present invention.

**Detailed Description of the Preferred Embodiments**

The present invention will now be described more fully hereinafter with reference to the accompanying drawings, in which preferred embodiments of the invention are shown. This invention may, however, be embodied in many different forms and should not be construed as limited to the embodiments set forth herein. Rather, these embodiments are provided so that this disclosure will be thorough and complete, and will fully convey the scope of the invention to those skilled in the art. Like numbers refer to like elements throughout.

The present invention is advantageous and provides a system and method for analyzing the customer local copper loop using a software module, also called the Bandwidth Analysis Tool (BAT) throughout this description. This software module analyzes the raw data results from a Wideband Test Pack (WTP), such as manufactured by Harris Corporation of Melbourne, Florida, and also the plant record data, to qualify and quantify the local copper loop under test for a

particular xDSL technology. Alternatively, the Bandwidth Analysis Tool can also analyze the WTP data and plant record data to recommend the best technology for a given application.

5           This analysis uses loop qualification and quantification based on WTP raw data results, plant record data, loop topology and the loop insertion loss. The loop is modeled to calculate the insertion loss, with or without bridged taps, taking into account the  
10 cable type, the wire gauge, loop length, and its topology. A signal-to-noise ratio of the receive signal is calculated using the specific technology, as dependent on the transmit signal power spectral density templates and noise versus frequency data results from  
15 the Wideband Test Pack. The downstream and upstream data rates are calculated for the local loop under test.

          The algorithm for loop qualification and quantification can have two principle functions: (1)  
20 determining physical loop faults; and (2) analyzing for xDSL technology.

          The determination of physical loops is performed by testing for shorts, opens, load coils, and similar factors. The xDSL technology testing analyzes  
25 for symmetric DSL or asymmetric DSL, as appropriate. Loop qualification is accomplished by testing for the presence or absence of load coils, impulse noise counts, ringer counts, and then comparing the counts with the thresholds specified by the given  
30 technologies. Loop quantification is accomplished for xDSL technologies by modeling the local loop under test, calculating the signal-to-noise ratio, and calculating the data rates. In the case of symmetric DSL technologies, downstream and upstream data rates  
35 are equal, as known to those skilled in the art. In

the case of asymmetric DSL technologies, downstream and upstream data rates are calculated based on downstream and upstream transmit signal power spectral densities (PSD), insertion loss, and noise versus frequency  
5 measurements.

Loop quantification for VDSL is performed as a special case because of the restrictions of the bandwidth of the Wideband Test Pack. In the case of VDSL, loop quantification is accomplished based on loop  
10 topology, rather than using signal-to-noise ratios. In a "recommend best technology" mode of the system, the technology is set to a DSL technology from a configurable list of technologies, and the analysis is performed for each technology in the list until the  
15 loop qualifies. Otherwise, the system continues analysis of the loop for the next technology on the list. If the list is exhausted, the program returns a "failed" status. If the loop qualifies for a DSL technology, the status is set to a "pass", and the  
20 recommended technology is set to the current technology for which the loop has been analyzed, and any calculated data rates are returned.

Referring now to FIG. 1, there is illustrated a typical Remote Test Unit to network element  
25 interconnection that uses a Wideband Test Pack and Bandwidth Analysis Tool software module of the present invention. Naturally, the Bandwidth Analysis Tool used as a software module can be adapted for use with different network elements and components, as suggested  
30 by those skilled in the art. The example as illustrated shows only one out of many different configurations.

The block diagram of FIG. 1 illustrates two home premises **10,12** having telephones and computers at  
35 the customer premise. These are connected to a remote



Incumbent Local Exchange Carrier (ILEC) **14** having a Digital Loop Carrier **16** and a Remote Test Unit **18**, such as a model 107A/F Remote Test Unit as manufactured by Harris Corporation of Melbourne, Florida, and a

5 Wideband Test Pack, such as are manufactured by Harris Corporation. A Central Office switch **20** as part of the Central office (CO) **20a** is connected to the Digital Loop Carrier **16** and to the other customer premises **12** via a Main Distribution Frame (MDF) **22**. An

10 Intermediate Distribution Frame **24** connects to the MDF **22**. A DSL Access Multiplexer (DSLAM) **30** is connected to the Intermediate Distribution Frame **24**, with operative connection to a Remote Test Unit **32**, such as a Harris model 105A, a Carrier Test Access Switch

15 (CTAS) **34**, such as manufactured by Harris Corporation, a Remote Test Unit **36**, such as a Harris model 107A/F, and a Wideband Test Pack **38**, located in a Colocation Cage **40**. The Remote Test Unit is connected to a stand alone PC **42** that could include a Test Access Express

20 circuit **42a**, similar in function to a Test Access Controller as manufactured by Harris Corporation. A Call Center **50** includes, as is normal in this example, an operator **52**, the Bandwidth Analysis Tool **54** of the present invention shown in block diagram and

25 representing a software module, and an Interactive Voice Access Server **56**.

A central component of the system is a Test Access Controller (TAC) **60**, which is a sophisticated software-based element of a test operational support

30 system. It provides communication and a control interface with remote test heads and interfaces with legacy systems and databases. It can be accessed through a graphical user interface **61** that is

windows-based to facilitate communications with call center personnel and other test operators.

As noted before, the test heads can include the Remote Test Unit, such as the model 105A, designed for use in the Central Office, and the model 107A/F, such as for a DLC environment and CLEC Colocation Cages. These Remote Test Units access lines by various ways, including a Carrier Test Access Switch to provide capacity of 128 lines, or a daisy-chaining circuit with up to seven other carrier test access switches to provide test access to over 1,000 lines. The Remote Test Unit can have direct access through the DSLAM or DLC, if there is metallic test access capability.

The Wideband Test Pack performs high frequency testing via the Remote Test Units, measuring high-frequency loss, noise margin, bridged taps, impulse noise and longitudinal balance. The Wideband Test Packet can provide data used by the Bandwidth Analysis Tool to determine what xDSL services a provider can offer a customer, in accordance with the present invention. The Wideband Test Pack can also generate tones for noise analysis. The Interactive Voice Access (IVA) technology shown at the Call Center can allow field technicians at either an ILEC or CLEC to gain access to testing functions and database records.

A Wideband Test Pack, such as manufactured by Harris Corporation, allows accurate, single-ended testing. The Wideband Test Pack can detect bridge taps, measure wideband circuit balance, measure high-frequency background noise, and provide a frequency spectrum line profile for identifying noise impairment. Also, double-ended tests can be performed to isolate problems.

Some of the operating ranges of a Wideband Test Pack that could be used in the present invention are listed below. Although these are only examples, these figures give a general idea of the type of specifications that a Wideband Test Pack or other device could have to obtain the raw data used by the Bandwidth Analysis Tool of the present invention.

**Wideband Noise** - Measures the total Gaussian noise up to 1500 KHz:

Frequency Range	4 KHz to 1500 KHz
Noise Level Range	0 dBrN to +120 dBrN
Accuracy	+/- 5%
Resolution	1 dB
Display Precision	1 dB

**Power Spectral Density/Noise Margin** - Provides detailed analysis of noise energy in DSL frequency bands:

Frequency Range	4 KHz to 1500 KHz
Frequency Band Sampling Range	4 KHz minimum
Power Spectral Density Range	0 dBrN to +120 dBrN
Accuracy	+/- 5%
Resolution	1 dB
Display Precision	1 dB

**Tone Generation & Measurement** - Applies and measures high frequency tones:

Frequency Range	4 KHz to 1500 KHz
Signal Level Range	-30 dBm to +30 dBm
Accuracy	+/- 5%
Resolution	1 dB
Display Precision	1 dB

**Impulse Noise** - Measures impulse noise at any frequency over DSL frequency range:

Event Threshold Range	-70 dBm to +30 dBm
Effective Frequency Range	4 KHz to 1500 KHz
Length of Test	10 to 3600 seconds

**Longitudinal Balance (Metallice to Longitudinal and Vice Versa)** - Longitudinal balance measurements verify the susceptibility of a copper pair to crosstalk and other noise sources:

Frequency Range	4 KHz to 1500 KHz
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	Frequency Band Sampling	
	Width	4 KHz minimum
	Circuit Balance Range	0 dB to +60 dB
	Accuracy	+/- 5%
5	Resolution	1 dB
	Display Precision	1 dB

10 **Bridge Tap Detection** - Bridge taps may severely limit the reach and speed of DSL signals due to reflections:  
Range up to 12,000 feet

**Control and Management** - Works with remote test unit.

15

Referring now to FIGS. 2 and 3, there are illustrated two flow charts showing the high level operation of the Bandwidth Analysis Tool (BAT) of the present invention and the operation of the BAT engine, as shown in FIG. 3. For purposes of illustration, the flow charts begin with reference numbers in the 100 series.

As shown in FIG. 2, the BAT system begins operation (Block 100) and a determination is made whether the mode equals the "best technology" (Block 101). There are two modes of operation: the first mode is the qualification of a line for a specific technology; the second mode recommends the best technology based on the application. In this flow chart, a determination is made of what mode the user desires to run, and if the mode equals the best technology, then a recommendation is received from a configurable list. The system software of the BAT queries a look-up table to obtain the first technology recommended for the application, and then qualifies the loop for that technology. As shown in Block 102, a recommendation order is obtained from a configurable list. The system sets a False status for "Done" (Block 104). The technology is set for the next technology (Block 106). If the last technology is not

equal to the technology (Block 108), then the BAT engine is called (Block 110). If the technology does equal the last technology, then "Done" is set to true (Block 111) and then the BAT engine run. If there is  
5 success in running the BAT engine (Block 112), then the technology, data rate and other status are returned (Block 114). If there is no success, and "Done" equals true (Block 116), then a failure is returned (Block 118). The system BAT software goes through the  
10 technology list until the loop qualifies for a technology, and then returns to the path and data rates. If it fails, then the loop did not qualify for any technologies for the application.

FIG. 3 illustrates the operation of the BAT engine by means of the high level flow chart as  
15 illustrated. The BAT engine is run (Block 170), and physical loop faults are determined (Block 172), such as by testing for shorts and testing for opens, and other similar tests. If there has been a failure  
20 (Block 174), then the status is set to failed (Block 176). If there has not been a failure, then the loop is qualified by testing for a load coil, impulse noise count, number of ringers, and other similar tests (Block 178). If there has been a failure based on the  
25 loop qualification (Block 179), then the status is set to failed (Block 176). If not, then the status is set to PASSED (Block 180) and Loop Quantification occurs (Block 182). At this point, the loop is modeled and the received signal PSD is calculated, as well as the  
30 signal-to-noise ratio. Data rates are calculated. Statuses and data rates are then returned (Block 184).

For purposes of description, the pseudo-code for the bandwidth analysis tool software module is explained below. These various pseudo-code segments  
35 are taken in order and described, starting with the

highest level and following to more detailed aspects of the Bandwidth Analysis Tool. Various inputs and outputs are described, as well as functions that are accomplished.

5

# 1. Pseudo-code BAT Engine

## Inputs:

Test Results from WTP, RTU and Plant data  
Threshold Data (technology and sub\_tech dependent),  
10 from a setup table  
Downstream and Upstream transmit Signal Data  
(technology dependent),  
Technology ID

## 15 Outputs:

Pass/Fail status  
Reason for failure and/or status information  
Downstream data rate  
Upstream data rate

20

Determine Physical Loop Faults  
Analyze loop for xDSL  
end of BAT Engine pseudo-code

25

As illustrated with the pseudo-code of the BAT engine, the various inputs include test results from the Wideband Test Pack, the Remote Test Unit and plant data. There are various thresholds that are technology  
30 dependent, such as the ringers and number of impulses that the technology will tolerate. These factors are all technology dependent and different thresholds are established for that specific technology, as known to those skilled in the art. This threshold data can be  
35 obtained from a set up table for the technology. Additionally, downstream and upstream transmit signal data are technology dependent. Examples include the level of the signal at the transmitter end, and the Power Spectral Density (PSD) of the signal that is  
40 allowed for specific technologies. For example, for various types of xDSL technology, the Power Spectral Density cannot exceed certain masks (or templates) for

each technology used at the transmit signal level. The technology ID confirms the technology identification.

The outputs can include a pass/fail status, reasons, and status information to show a lack of  
5 needed input data to form a concrete analysis. There could be some confidence level that is gained concerning the analysis and the reasons why the test may have failed or passed, such as if there were detected ringers, bridge taps and other similar items.  
10 The downstream/upstream data rate also is obtained.

At the next level, the loop is analyzed for xDSL, corresponding to the various DSL technologies. This occurs after the determination of physical loop faults.

15

## 2. Pseudo-code to Determine Physical Loop Faults

### Inputs:

Test Results from WTP, RTU and Plant data  
Technology dependent Threshold Data (technology  
20 dependent)  
Technology ID

### Outputs:

Pass/Fail status  
25 Reason of failure

If Load Coil Information is Available

If Load Coil Present

30 Set PassFail = FAIL;  
Set status Load Coil Present;

else

35 Set PassFail = PASS;

else

Set Reason for failure, Load Coil Information Not Available

40

Physical loop faults are determined with similar inputs as before, such as the test results from the WTP, RTU and plant data. It is technology

dependent with threshold data, and a technology ID.  
The outputs include a pass/fail status and the reason  
for the failure. Load coil information is necessary to  
determine the physical loop faults because the load  
5 coils have an adverse effect on the DSL technology.  
Based on the xDSL technology, a different analysis is  
accomplished. The system also checks to determine what  
technology the system is qualifying the loop, such as  
symmetric DSL or asymmetric DSL.

10

### 3. Pseudo-code to Analyze XDSL

#### Inputs:

Test Results from WTP, RTU and Plant data,  
Threshold Data (technology dependent),  
15 Downstream and Upstream transmit Signal Data  
(technology dependent),  
Technology ID

#### Outputs:

20 Pass/Fail status  
Reason of failure  
Downstream data rate  
Upstream data rate  
25 switch (Technology ID)

```
        // symmetric technologies
        case BAT_HDSL:
        case BAT_HDSL_1160:
        30 case BAT_HDSL_584:
        case BAT_HDSL_392:

        case BAT_SDSL:
        case BAT_SDSL_144:
        35 case BAT_SDSL_400:
        case BAT_SDSL_784:
        case BAT_SDSL_1040:
        case BAT_IDSL:
        Analyze Symmetric DSL;
        40 break;

        // Asymmetric technologies
        case BAT_ADSL:
        case BAT_RADSL:
        45 case BAT_HDSL2:
        Analyze Asymmetric DSL;
```



```

// VDSL is processed separately
case BAT_VDSL:
AnalyzeVDSL;
break;
5
    default:
        set PassFail = FAIL
        set Reason for failure, technology not
10 supported
        // end switch (Technology ID)
        // end Analyze XDSL

15
    When analyzing the xDSL, it is evident that an
    analysis occurs based on the technology with a
    different analysis depending on what technology is
    being analyzed, such as HDSL, SDSL, ADSL, RADSL, HDSL2
    and other possible xDSL technologies.

20
4. Pseudo-code to Analyze Symmetric DSL
    Inputs:
        Test Results from WTP, RTU and Plant data
        Threshold Data (technology dependent)
25        Downstream and upstream transmit Signal Data
        (technology dependent)
        Technology ID

    Outputs:
30        Pass/Fail status
        Reason of failure
        Downstream data rate
        Upstream data rate

35        Qualify Loop
        if Loop Qualified

            switch (Technology ID)

40                case BAT_HDSL:
                case BAT_HDSL_1160:
                case BAT_HDSL_584:
                case BAT_HDSL_392:
                    Quantify HDSL
45                    break;

                case SDSL:
                    case SDSL_144:
                    case SDSL_400:
```

```

                                case SDSL_784:
                                case SDSL_1040:
                                case SDSL_1568:
                                  QuantifySDSL
5                                break;

                                case BAT_IDSL:
                                  Quantify IDSL
10                               break;

                                // end switch (Technology ID)

                                // end Analyze Symmetric DSL

15                               When analyzing symmetric DSL, the loop is first
                                qualified and then the BAT system quantifies HDSL,
                                followed by quantifying SDSL, and then IDSL.

20 5. Pseudo-code to Analyze Asymmetric DSL
    Inputs:
        Test Results from WTP, RTU and Plant data,
        Threshold Data (technology dependent),
        Signal Data (technology dependent),
25     Technology ID

    Outputs:
        Pass/Fail status
        Reason for failure
30     Downstream data rate
        Upstream data rate

        Qualify Loop
        Quantify Loop
35

    // end Analyze Asymmetric DSL

    When analyzing asymmetric DSL, test inputs are
40 similar as before, and the outputs include a reason for
    failure after a pass/fail status, a downstream data
    rate, and upstream data rate. The loop is qualified
    with one routine, and then quantified with another
    routine, as defined in the next two sections of pseudo-
45 code, which explain the qualification and
```

quantification of the loop in accordance with the present invention.

**6. Pseudo-code to Qualify Loop**

```
5  Inputs:
    Test Results from WTP, RTU and Plant data,
    Threshold data (technology dependent),
    Technology ID

10 Outputs:
    Pass/Fail status
    Reason of failure

    if Load coil information available
15
        if Load coil present
            set Pass/Fail status = FAIL;
            Set Reason of failure status, Load Coil
Present = TRUE;
20        else

            LcoilPresent Status = FALSE;

        else
25            set status Load Coil Information Not Available
= NOT_AVAILABLE;

            if Impulse Noise test results available
30
                if Impulse Noise Count less than threshold
count
                    set status ImpulseCountHigh = PASS
35                else

                    set status PassFail = FAIL
                    set status ImpulseCountHigh = FAIL
40            else

                set status WimpulseTestNotAvailable = NOT_AVAILABLE

45            if Number of Ringers less than threshold
                set Reason of failure status RingerFault = PASS
            else
                set status PassFail = FAIL
                set Reason of failure status RingerFault = FAIL
50
// end Qualify Loop
```

When qualifying the loop, various test results from the WTP, RTU and plant data are input, together with the threshold data and technology ID. The outputs  
5 include a pass/fail status and the reason for the failure. For example, load coil information, impulse noise test, and the number of ringers is determined. In the quantification of the loop, signal data is also an input with the data rates as an output. The loop is  
10 modeled and can be identical for both directions. The Power Spectral Density (PSD) of transmit data is established for downstream transfers, and a signal-to-noise ratio array is set up for downstream transfers. The downstream data rate is calculated and the Power  
15 Spectral Density of transmit data is established for upstream transfers. The signal-to-noise ratio array is established. The upstream data rate is then calculated.

#### 7. Pseudo-code to Quantify Loop

20 Inputs:

Test Results from WTP, RTU and Plant data,  
Threshold data (technology dependent),  
Signal Data (technology dependent),  
Technology ID

25

Outputs:

Pass/Fail status  
Reason of failure  
Downstream data rate  
30 Upstream data rate

30

Model Loop (note: currently identical for both directions)

35     setup power spectral density of transmit data for downstream transfers  
       setup downstream signal-to-noise-ratio array  
       calculate downstream data rate

40     setup power spectral density of transmit data for upstream transfers  
       setup upstream signal-to-noise-ratio array  
       calculate upstream data rate

// end Quantify Loop

For the signal-to-noise ratio, the loop is modeled to determine loop attenuation at the receiving end. A signal-to-noise ratio is calculated using the well known Shannon Theorem to calculate the downstream data rate.

Shannon's Theorem gives an upper bound to the capacity of a link, in bits per second (bps), as a function of the available bandwidth and the signal-to-noise ratio of the link. The theorem can be stated as:

$$C = B * \log_2 (1 + S/N)$$

where C is the achievable channel capacity, B is the bandwidth of the line, S is the average signal power, and N is the average noise power. The signal-to-noise ratio (S/N) is usually expressed in decibels (dB) given by the formula:

$$10 * \log_{10} (S/N).$$

Thus, a signal-to-noise ratio of 1,000 could commonly be expressed as:

$$10 * \log_{10} (1000) = 30 \text{ dB}.$$

The pseudo-codes to model the loop and to calculate the loop's ABCD matrices are set forth below. The loop is modeled using inputs as the number of channels, the start frequency, the delta frequency, test results, and technology ID with an output as loop data. Source and load impedances are used, together with the wire gauge information, if available. When calculating the loop's ABCD matrices, the inputs include the number of channels, the start frequency, delta frequency, length of the segment, wire gauge, bridged tap flag, and loop data. The RLCG constants are also modeled (Resistance, Inductance, Capacitance and Conductance), together with the model line parameters. Following the pseudo-code for calculating the loop's ABCD matrices, the pseudo-codes to model the primary constants RLCG,

the insertion loss, the line parameters, the signal-to-noise ratio, and the data rate are set forth.

**8. Pseudo-code to Model Loop**

```
5  Inputs:
    Number of Channels,
    Start Frequency,
    Delta Frequency,
    Test Results,
10  Technology ID,

    Outputs:
    Loop Data

15  set source and load impedances
    If Wire Gauge Information available
        Set Wire Gauge
    Else
        Set Wire Gauge to default wire gauge
20  If Bridged Tap Information is not available
        Set number of taps to zero
    Else
        Calculate Loop's ABCD matrices
25  Calculate Insertion Loss of the loop

// end Model Loop
```

**9. Pseudo-code to Calculate Loop's ABCD Matrices**

```
Inputs:
    Number of Channels
    Start Frequency
35  Delta Frequency
    Length of the segment
    Wire Gauge
    Bridged Tap Flag
    Loop Data
40

Output:
    Loop Data

    initialize loop [ABCD] to unity
45  do for all segments of the loop

        Do for the frequency range
            Model the RLCG Constants
            Model Line Parameters
50  If it is Bridged Tap section
```

```

        A = 1
        B = 0
        C = Ctanh (Gamma)
        D = Ctanh(Gamma)/Z0;
5  else
        A = D = Ccosh (Gamma)
        B = Csinh(Gamma) * Z0;
        C = Csinh(Gamma) /Z0;

10  Multiply by the accumulated [ABCD] from previous
    segments

        // end do for the frequency range
        end do for all segments of the loop
15  // end Calculate loop's ABCD matrices

20  10. Pseudo-code to Model the Primary Constants RLCG
    Inputs:
        Frequency in kHz
        Wire Gauge

25  Outputs:
        Primary Constants, RLCG

        if Wire Gauge Information Available
            set cable model parameters based on the wire
30  gauge
        else
            set cable model parameters using average of
            AWG_24 and AWG_26

35  Calculate Primary Constants, RLCG

11. Pseudo-code to Calculate Insertion Loss
40  Do for all channels
        set load impedance (Z_load) for the current
        technology
        set source impedance (Z_source) for the
45  current technology
        Insertion Loss = 20 * log (abs ((A * Z_load +
        B + Z_source *
            (C * Z_load +D))/Z_source + Z_load)))

50  // end of for all channels} // end of Calculate
    Insertion Loss
```

**12. Pseudo-code to Calculate Line Parameters**

Inputs:

5        Frequency  
      Primary Constants (RLCG)

Outputs:

      Line Parameters

10         $Z = R + j \cdot 2 \cdot \pi \cdot f \cdot L;$   
           $Y = G + j \cdot 2 \cdot \pi \cdot \text{Frequency} \cdot C;$   
           $\Gamma = \sqrt{Z \cdot Y};$   
           $Z_0 = \sqrt{Z/Y};$

15    // end Calculate Line Parameters

**13. Pseudo-code to Setup Signal to Noise Ratio**

20    Inputs:

          Number of channels  
          Start Frequency  
          Delta Frequency  
          PSD data

25        Wmargin data  
          Loop data  
          Downstream flag

Outputs:

30        Signal to noise ratio for all channels

      Do for all channels  
          convert transmit signal PSD from dBm/Hz to dB  
          calculate signal level at receiver end

35        convert noise to dB  
           $\text{signal to noise [dB]} = \text{signal [dB]} - \text{noise [dB]}$

      // end for all channels  
      // end Setup Signal to Noise Ratio

40

**14. Pseudo-code to Calculate Data Rate**

Inputs:

45        Bat Results  
          Number of Channels  
          Start Frequency  
          Delta Frequency  
          Signal to noise data

50        Technology ID  
          Downstream flag

Outputs:



Downstream/upstream data rate

```
Switch (Technology ID)
  case BAT_ADSL:
5      if (Downstream)
          for channels 33 through 255 (excluding
channel 64)
              signal_to_noise [dB] =
signal_to_noise - snr_margin - snr_gap
10              if (signal_to_noise > 0)

                  Delta Capacity = log2(1 +
pow(10.0,0.1*signal_to_noise [dB]))
                  If (Delta Capacity > MAX_BIT)
15                      Delta Capacity = MAX_BIT
                  If (Delta Capacity < MIN_BIT)
                      Delta Capacity = MIN_BIT

                  Downstream Data Rate = Downstream
20 Data Rate +
                      Delta Capacity * data_frame_rate

              else
                  for channels 6 through 31 (excluding
25 channel 16)
                      signal_to_noise [dB] =
signal_to_noise - snr_margin - snr_gap
                      if (signal_to_noise > 0)

30                      Delta Capacity = log2(1 +
pow(10.0,0.1*signal_to_noise [dB]))
                      If (Delta Capacity > MAX_BIT)
                          Delta Capacity = MAX_BIT
                      If (Delta Capacity < MIN_BIT)
35                          Delta Capacity = MIN_BIT

                      Upstream Data Rate = Upstream Data
Rate + Delta Capacity * data_frame_rate

40      break;

      case HDSL2:
          Not implemented yet

45      break;

      case BAT_VDSL:

          break;

50      default:
          for all channels
```

```

                                signal_to_noise ratio =
signal_to_noise ratio - snr_margin - snr_gap
                                if (signal_to_noise_ratio > 0)

5                                Delta Capacity = log2(1 + pow(10,
                                0.1 * signal_to_noise ratio))
                                Total Capacity = Total Capacity +
                                Delta Capacity * data_frame_rate

10                                // Calculate data rate
```

15           It is evident that the present invention is operable to take the raw data from various test units, and more particularly, the Wideband Test Pack, Remote Test Units, and plant record data to qualify and quantify a local loop under test for a particular DSL  
20           technology. Also, the WTP, RTU, and plant record data can be analyzed to recommend the best technology for a given application in an efficient manner.

          Many modifications and other embodiments of the invention will come to the mind of one skilled in  
25           the art having the benefit of the teachings presented in the foregoing descriptions and the associated drawings. Therefore, it is to be understood that the invention is not to be limited to the specific embodiments disclosed, and that the modifications and embodiments are intended  
30           to be included within the scope of the dependent claims.